

## Index

### **a**

absorption  
 electron microscopy 161–164  
 infrared spectroscopy 190–191  
 X-ray spectroscopy 77–92  
 activation energy 39–40, 150–151, 156–157  
 active pharmaceutical ingredients (API) 33–34  
 AES *see* Auger electron spectroscopy  
 ammeters 109–110  
 angle of scattering 164  
 angular momentum 98–99  
 antiferromagnetic materials 11, 111, 118–125  
 anti-scatter-slits 23  
 anti-stoke scattering 44, 47  
 API *see* active pharmaceutical ingredients  
 atomic force microscopy 175–179  
 atomic orbital terminology 98–99  
 atomic polarization 131–133, 135–136, 143–144  
 atomic radius 130, 133  
 atomic scattering factor 16–17  
 attenuated total reflectance (ATR) 186–188, 194  
 Auger electrons 78–79, 84–86, 93–95, 99–106  
 Auger electron spectroscopy (AES) 99–106  
 Auger process 101–103  
 electron-matter interactions 100  
 electron yield 100–101  
 energy levels 93–94, 99–106  
 fundamentals 99–100  
 instrumentation 105–106  
 ionization 102–103  
 matter-electron interactions 100  
 plasmons 104

relaxation 102–103

spectral features 104–106

Auger emission 102–103, 163–164

automatic IR spectroscopy analysis 195–196

### **b**

back-reflection 27, 29–30  
 backscattering 60–61, 80–81, 104–106, 161, 164, 172  
 beamline components 84  
 beam splitting 188–189  
 Beer–Lambert law 45  
 Beer's law 79  
 binding energy 77, 81, 93–99, 103  
 Bragg's Law 17–18, 20–23, 27, 32  
 Bravais lattices 7–9  
 Bremsstrahlung X-rays 166  
 broadening 31–33

### **c**

calibration, Raman spectroscopy 56–57  
 capacitance/capacitors 129–130, 136–137, 141–142  
 charge-coupled devices 53  
 charge density 130–133, 137, 140–145  
 charge hopping 137, 146–147  
 charge-ordered insulating phases 122–123  
 chemical enhancement, Raman spectroscopy 60  
 chemistry, IR spectroscopy 193–194  
 classical theory, Raman scattering 47–48  
 clinical practice, IR spectroscopy 193–194  
 colossal dielectric response 137  
 colossal magneto-resistance (CMR) 122  
 combination bands, IR spectroscopy 192

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complex dielectric constant 11–12  
 complex optical conductivity 11  
 complex permittivity 141–142  
 conductivity 11, 150–151  
 continuum levels 79–81  
 control systems, Raman spectroscopy 52–53  
 copper spectra 106  
 counters, Raman spectroscopy 52–53  
 coupling, IR spectroscopy 192  
 Crewe, Albert 175  
 critical frequencies, dielectrics 147  
 crystal field effects 63, 86, 89–92  
 crystallography  
     fundamentals of 1, 4–9  
     Raman spectroscopy 64  
     X-ray diffraction 19–20, 27–29, 183  
     X-ray spectroscopy 77  
 crystal orientation 27–29  
 cubic crystal system 7–9  
 Curie method, susceptibility  
     measurements 117  
 Curie temperatures 123  
 current density 140–145

**d**

DC SQUID magnetometers 115  
 Debye relaxation 144  
 density, dielectrics 130–133, 137, 140–145  
 detectors/detection  
     FTIR spectroscopy 184–188  
     Raman spectroscopy 52–53  
     X-ray diffraction 21–26  
 diagnosis techniques 194–195  
 diamagnetic materials 10, 111, 116–117  
 diamond anvil cells 55–61  
 dielectric constant 11–12, 129–143, 147–157, 179  
 dielectric measurements 129–158  
     atomic polarization 131–133, 135–136,  
         143–144  
     build up of polarization 142–144  
     capacitance 129–130, 136–137, 141–142  
     colossal response 137  
     complex permittivity 141–142  
     Debye relaxation 144  
     dielectric loss 129–130, 141, 144–155  
     dielectric material classification 138–140  
     dipolar polarization 132–134, 138–140,  
         149, 152–153  
     dipole moments 130–136, 139–140

dispersion 140, 150, 153–154  
 dissipation 129–130, 136–137, 140–142,  
     148–149, 156  
 electronic polarization 131–139, 143–144,  
     149, 152  
 $\text{EuFe}_{1-x}\text{Mn}_x\text{O}_3$  151–157, 180  
 frequency dependence 138, 143–157  
 hopping charge transport 137, 146–147  
 interfacial polarization 136–137  
 ionic polarization 131–132, 136–139, 149,  
     152–153  
 Jonscher's universal law 144–147, 153–154  
 macroscopic properties 130–140  
 manganese doping  
     concentrations 151–157  
 material classification 138–140  
 optical polarization 131–133  
 orientational polarization 134–135, 143–144  
 permittivity 141–142  
 polarization 130–157  
 $\text{PrFe}_{1-x}\text{Mn}_x\text{O}_3$  148–151  
 relaxation 141, 144–147  
 susceptibility 131, 145–147, 152–153  
 temperature dependence 134–137,  
     140–157  
 valence electrons 139  
 diffraction, X-ray diffraction 15–42, 183  
 diffractometers 16, 21–24, 27–31  
 diffuse reflectance infrared Fourier transform  
     (DRIFT) 186–187  
 dipolar dielectric materials 139–140  
 dipolar polarization 132–134, 138–140, 149,  
     152–153  
 dipole moments 130–136, 139–140, 190–191  
 direction, crystallography 6–7  
 direct X-ray diffraction 16  
 disease diagnosis 194–195  
 dispersion, dielectric 140, 150, 153–154  
 dissipation, dielectric 129–130, 136–137,  
     140–142, 148–149, 156  
 divergence slits 23  
 DRIFT *see* diffuse reflectance infrared Fourier  
     transform

**e**

EDX *see* energy dispersive analysis of X-ray  
 EFMO *see*  $\text{EuFe}_{1-x}\text{Mn}_x\text{O}_3$   
 elastic scattering 44–50, 57, 160, 164–165  
 electrical resistivity 129, 149–150

- electrochemistry 60–61  
 electromagnetic spectrum 2–4, 183–184, 190  
 electron-accelerating voltages 170–171  
 electron beam generation 159–160  
 electron beam interaction 160–161  
 electron hole pairs 25  
 electronic integrators 110–114  
 electronic polarization 131–139, 143–144,  
     149, 152  
 electronic structures, X-ray absorption  
     spectroscopy 86–92  
 electron-matter interactions 100  
 electron microscopy 159–181  
     absorption 161–164  
     atomic force microscopy 175–179  
     Auger emission 163–164  
     backscattering 161, 164, 172  
     elastic scattering 160, 164–165  
     electron beam generation 159–160  
     electron beam interaction 160–161  
     energy levels 162–167, 170–173, 179–180  
 $\text{EuFe}_{1-x}\text{Mn}_x\text{O}_3$  178–181  
     excited atoms 162–164  
     fundamentals 159–161  
     inelastic scattering 160–165  
     inner shell excitation 161  
     instrumentation 164–181  
 $\text{La}_{x-1}\text{Ca}_x\text{MnO}_3$  177–179  
     phonon scattering 160  
 $\text{PrFe}_{1-x}\text{Mn}_x\text{O}_3$  177–178  
     relaxation 162–164  
     samples 160–161  
     scattering 160–165  
     secondary electrons 161, 164, 173–175  
     types 164–181  
     valence electrons 159–161  
     X-ray interactions 160–167, 171, 179  
 electron spectroscopy for chemical analysis  
     (ESCA) 78, 92–99  
 electron wavelengths 167  
 electron yield mode 77–85, 100–101  
 elemental analysis,  $\text{EuFe}_{1-x}\text{Mn}_x\text{O}_3$  178–181  
 Elmer, Perkin 183  
 energy dispersive analysis of X-ray (EDX) 18,  
     179–181  
 energy levels  
     Auger electrons 93–94, 99–106  
     electron microscopy 162–167, 170–173,  
     179–180  
     Raman spectroscopy 48, 53–55  
     X-ray diffraction 15  
     X-ray spectroscopy 77–83, 86–106  
 energy referencing 94–95  
 environmental IR spectroscopy  
     studies 195–196  
 ESCA *see* electron spectroscopy for chemical  
     analysis  
 $\text{EuFe}_{1-x}\text{Mn}_x\text{O}_3$  (EFMO)  
     dielectrics 151–157, 179  
     electron microscopy 178–181  
     elemental analysis 178–181  
     energy dispersive analysis of  
         X-rays 179–181  
     manganese doping  
         concentrations 151–157  
     morphological studies 178–181  
     scanning electron microscopy 178–181  
     X-ray diffraction 38–40  
 EXAFS *see* extended X-ray absorption fine  
     structure spectroscopy  
 excitation, Raman spectroscopy 50–53, 58–62  
 excited atoms 162–164  
 experimental aspects  
     Bragg's Law 20–21  
     X-ray absorption spectroscopy 83–86  
     X-ray diffraction 20–21  
 extended X-ray absorption fine structure  
     spectroscopy (EXAFS) 80–83, 89–92  
 extraction, magnetization  
     measurements 111–113
- f**
- Faraday's law 110, 113  
 far-infrared spectroscopy 183, 188  
 FC *see* field-cooled  
 FEI TITAN Themis 170  
 Fermi levels 79–80, 94–95  
 Fermi resonance 192  
 ferrimagnetic materials 11  
 ferroelectric dielectric materials 138  
 ferromagnetic materials 11, 111, 118–125  
 field-cooled (FC) magnetization 118–120,  
     125–126  
 field dependence, magnetization 114–116,  
     120–125  
 fluorescence X-rays 78, 84–86, 100–101  
 fluorescence yield 163  
 fluorescent photons 78–79

- flux density 130–133, 137, 140–145  
 fluxmeters 110–114  
 focusing circles 21–22  
 Foner magnetometers 113–116  
 food-stuff analysis 187, 192–195  
 forensic science 33–34  
 Fourier transform (FT)–Raman spectroscopy 44, 52–53  
 Fourier transform infrared (FTIR) spectroscopy 183–189, 194–195  
 Fourier transforms (FT) 189–190  
 frequency dependence, dielectrics 138, 143–157
- g**  
 gamma rays 4  
 gas analysis 187, 192, 195–196  
 gas discharge 168  
 gas proportional detectors 24–25  
 geological investigations 34  
 geometry, X-ray diffraction 21–26  
 Gouy method 117  
 grain size 29–30
- h**  
 HATR *see* horizontal attenuated total reflectance  
 hexagonal crystal system 8–9  
 high-angle annular dark field (HAADF) detectors 175  
 high-pressure Raman spectroscopy 55–57  
 HITACHI-SU scanning electron microscopy 174  
 hopping models 123, 137, 146–147  
 horizontal attenuated total reflectance (HATR) 188
- i**  
 illumination, Raman spectroscopy 51  
 incident photon energy 44–45  
 inelastic scattering 44–60, 64, 160–165  
 infrared (IR) absorption 190–191  
 infrared (IR) radiation 3–4, 184  
 infrared (IR) spectroscopy 183–197  
     absorption 190–191  
     applications 192–196  
     chemistry 193–194  
     clinical practice 193–194  
     complicating factors 192  
     disease diagnosis 194–195  
     environmental applications 195–196  
     food-stuff analysis 187, 192–195
- gas analysis 187, 192, 195–196  
 interpretation complications 192  
 mechanisms 45–46  
 normal vibration modes 191  
 plants 194  
 Raman spectroscopy 43–46, 53–55, 59–60, 63–66  
 remote sensing 195–196  
 solid surface analysis 187–188, 196  
 vibrational transitions 43–46, 53–55, 59–60, 63–66, 191
- inner shell excitation 161  
 instrumentation  
     Auger electron spectroscopy 105–106  
     FTIR spectroscopy 184–189  
     magnetic measurements 111–115  
     magnetization measurements 111–115  
     Raman spectroscopy 43–44, 50–58  
     X-ray absorption spectroscopy 83–86, 105–106  
     X-ray diffraction 21–26  
     X-ray photoelectron spectroscopy 96–97  
 interfacial polarization 136–137, 149–150, 152–153  
 interference filters 51–52  
 interferometers 184–189  
 ionic polarization 131–132, 136–139, 149, 152–153  
 ionization 102–103  
 IR *see* infrared  
 iron  
     electronic structure 91–92  
     manganese doping replacement 62–64
- j**  
 JEOL grand ARM 168, 170  
 Jonscher's universal law 144–147, 153–154  
 Josephson tunneling 114–116
- k**  
 KBr pellets 186–188  
 kidney disease diagnosis 195  
 kinetic energy 92–97, 103–104  
 Koop's model 149
- l**  
 lamps, Raman spectroscopy 43–44  
 laser interferometers 185–186  
 lattice constants/parameters 35–36, 38–40  
 lattices 5–9

Laue equation 18–20, 27  
 Laue treatment 15, 18–20, 27  
 $\text{La}_{x-1}\text{Ca}_x\text{MnO}_3$  (LCMO)  
     atomic force microscopy 177–179  
     electron microscopy 177–179  
     magnetic measurements 120–125  
     Raman spectroscopy 64–67  
     temperature dependence 65–71  
     X-ray absorption spectroscopy 86–88  
     X-ray diffraction 37–38  
 light–water interactions 44

**m**

macroscopic properties, dielectrics 130–140  
 magnetic/magnetization  
     measurements 109–127  
     examples and illustrations 117–125  
     extraction technique 111–113  
     field dependence 114–116, 120–125  
     fluxmeters 110–114  
     instrumentation 111–115  
 $\text{La}_{x-1}\text{Ca}_x\text{MnO}_3$  120–125  
 magnetometers 111, 113–116  
 $\text{PrFe}_{1-x}\text{Mn}_x\text{O}_3$  117–120  
 SQUID magnometers 111, 114–116  
 susceptibility 116–117, 119  
 vibrating sample magnetometers 111, 113–116

magnetism  
     discovery 109–111  
     solids 10–11

magnetite 109

magnetometers 111, 113–116

manganese doping concentration 62–64, 151–157

material classification 138–140

matter-electron interactions 100

Maxwell's equation 11–12

metal ultrastructures 170–171

Michelson interferometers 184–185

microprobes 57–59

microscopy  
     dielectrics 140, 150, 153–154  
     electron microscopy 159–181  
     Raman microscopy 57–59

microwaves 3, 183, 190

mid-infrared spectroscopy 183–184, 188, 193–194

Miller indices 7

mirrors, X-ray diffraction 23–24

$\text{MnO}_3$  spectra 86–88  
 molecular bonds 44  
 molecular vibrations 10  
 monochromators 23–24, 183  
 monoclinic crystal system 8–9  
 morphology,  $\text{EuFe}_{1-x}\text{Mn}_x\text{O}_3$  178–181  
 multi-layer mirrors 23–24

**n**

near-edge X-ray absorption spectroscopy (NEXAFS) 80–82, 89–92  
 near-infrared spectroscopy 183–187, 192–194  
 non-ferroelectric dielectric materials 138–140  
 non-polar dielectric materials 139  
 normal vibration modes 191

**o**

Oatley, Charles 173–174  
 O K edge spectra 86–90  
 optical band gaps 150–151  
 optical conductivity 11  
 optical fibers 23–24  
 optical polarization 131–133  
 optical properties, solids 11–12  
 optical schematics, FTIR  
     spectrometers 187–189  
 optics, X-ray diffraction 23–24  
 orientational polarization 134–135, 143–144  
 orientation aspects, X-ray diffraction 27–29  
 origin, Raman spectra 45–46  
 orthorhombic crystal system 8–9  
 overtone, IR spectroscopy 192

**p**

paramagnetic materials 10–11, 111, 116–117, 122–125, 138–139  
 particle size 30–31  
 Patterson technique 16  
 peaks  
     Raman spectroscopy 66–68  
     X-ray diffraction 26  
 permittivity 141–142  
 perturbation theory 48–53  
 pesticides 196  
 pharmaceuticals 33–34  
 phonons 66, 69, 160  
 photodiode array detectors 52–53  
 photoelectric effect 78, 92–99  
 photoelectrons 78, 80–86, 92–99  
 photomultiplier (PM) tubes 52–53

photon counting 52–53  
 photon energy 44, 78–82, 87–97, 166  
 plants, IR spectroscopy 194  
 plasmons 160  
 plotting methods 28–29  
 PM *see* photomultiplier tubes  
 polar dielectric materials 139  
 polarizability 44, 47–51, 54, 59–60, 134–157  
 polarization  
     buildup 142–144  
     dielectrics 130–157  
 pollutants, IR spectroscopy 196  
 polycrystalline aggregates 29–33  
 polycrystalline crystals 27–29  
 powder methods 21–23, 33–34  
 $\text{PrFe}_{1-x}\text{Mn}_x\text{O}_3$   
     atomic force microscopy 177–178  
     dielectrics 148–151  
     electron microscopy 177–178  
     magnetic measurements 117–120  
     Raman spectroscopy 62–64  
     silicon substrates 117–120  
     X-ray absorption spectroscopy 88–92  
     X-ray diffraction 34–36  
 $\text{PrFeO}_3$  spectra 88–92  
 properties, polycrystalline crystals 27–29

**q**

quality, polycrystalline aggregates 31–33  
 quantum numbers 98–99  
 quantum theory 48–53  
 quasi-d.c. processes, (QDC) 152–153

**r**

radiation dipoles 49–50  
 radio waves 3  
 Raman active modes 44, 48, 57, 63  
 Raman band intensity 53–55  
 Raman, C. V. 43  
 Raman microscopy 57–59  
 Raman scattering 44–55, 57–60, 64  
 Raman shift 44  
 Raman spectra 45–46, 62–66  
 Raman spectroelectrochemistry 60–61  
 Raman spectrometers 43–44, 50–58  
 Raman spectroscopy 43–76  
     applications and illustrations 62–71  
     control systems 52–53  
     detection 52–53  
     diamond anvil cells 55–61

elastic scattering 44–50, 57  
 electrochemistry 60–61  
 energy levels 48, 53–55  
 excitation 50–53, 58–62  
 high-pressure technique 55–57  
 illumination 51  
 inelastic scattering 44–55, 57–60, 64  
 instrumentation 43–44, 50–58  
 interference filters 51–52  
 IR spectroscopy 43–46, 53–55, 59–60, 63–66  
 $\text{La}_{x-1}\text{Ca}_x\text{MnO}_3$  64–67  
 manganese doping concentrations 62–64  
 mechanisms 45–46  
 perovskites 62–66  
 perturbation theory 48–53  
 polarizability 44, 47–51, 54, 59–60  
 $\text{PrFe}_{1-x}\text{Mn}_x\text{O}_3$  62–64  
 quantum theory 48–53  
 Raman microscopy 57–59  
 Raman scattering 44–55, 57–60, 64  
 Raman spectroelectrochemistry 60–61  
 Rayleigh scattering 44–50, 57  
 resonance 53–54, 60–62  
 sample holders 51  
 scattering 44–66  
 source 50–51  
 special techniques 55–61  
 spectrometers 43–44, 50–58  
 surface-enhanced 59–60  
 techniques 55–61  
 temperature dependence 65–71  
 vibrational transitions 43–48, 53–55, 59–60, 63–66  
 Rayleigh scattering 44–50, 57  
 reflectance, FTIR spectroscopy 186–188, 194  
 relaxation 102–103, 141, 144–147, 162–164  
 remote sensing 195–196  
 resistivity, dielectrics 129, 149–150  
 resonance Raman spectroscopy 53–54, 60–62  
 RF SQUID magnetometers 115  
 rhombohedral crystal system 8–9  
 Rietveld method 16, 38–39  
 Rietveld Refinement Fullproof code 38–39  
 rings, magnetization 109–111, 115  
 Rontgen, Wilhelm C. 15  
 rotating crystal method 20–21, 27–28  
 rotation axes, X-ray diffraction 27  
 Ruby Scale 56  
 Ruska, Ernst 167

**S**

sample handling/holders  
 electron microscopy 160–161  
 FTIR spectroscopy 186–187  
 Raman spectroscopy 51  
 X-ray diffraction 21–23, 27–28  
 scanning electron microscopy (SEM) 164, 166, 172–175, 178–181  
 scanning speed, FTIR spectroscopy 188–189  
 scanning transmission electron microscopy (STEM) 165, 174–176  
 scanning transmission X-ray microscopy (STXM) 166  
 scattered photon energy 44  
 scattering  
   electron microscopy 160–165  
   Raman spectroscopy 44–66  
   X-ray diffraction 16–17  
 scintillation detectors 25  
 screening charge hopping 146  
 secondary electrons 161, 164, 173–175  
 secondary windings 110  
 SEM *see* scanning electron microscopy  
 Siemens Company, Germany 168–169  
 silicon substrates,  $\text{PrFe}_{1-x}\text{Mn}_x\text{O}_3$  117–120  
 simple cubic crystal system 7–9  
 single crystal orientation 27–29  
 single valence electron excitation 160  
 size aspects, polycrystalline aggregates 29–30  
 slit systems 23–24  
 solids  
   magnetism 10–11  
   optical properties 11–12  
 solid state detectors 25–26  
 solid surface analysis 187–188, 196  
 soller slits 23  
 spectral features  
   Auger electron spectroscopy 104–106  
   Raman spectroscopy 45–46, 62–66  
   X-ray photoelectron spectroscopy 97–99  
 spectrometers, Raman spectroscopy 43–44, 50–58  
 spin configurations 119–120  
 spin-orbit interactions 98–99  
 spontaneous emissions 51  
 SQUID *see* superconducting quantum interference devices  
 SQUID magnetometers 111, 114–116  
 standard X-ray diffraction pattern 26  
 stimulated absorption 51

stimulated emissions 51

stoke scattering 44, 47

strain/stress 31–33

superconducting quantum interference devices (SQUID) 111, 114–116

surface-enhanced Raman spectroscopy 59–60

susceptibility

  dielectrics 131, 145–147, 152–153

  magnetization 116–119

synchrotron radiation 83–84

**T**

TEM *see* transmission electron microscopy

temperature dependence

  dielectrics 134–137, 140–157

$\text{La}_{x-1}\text{Ca}_x\text{MnO}_3$  120–125

  polarizability 134–137, 140–157

$\text{PrFe}_{1-x}\text{Mn}_x\text{O}_3$  119–120

  Raman spectroscopy 65–71

tetragonal crystal system 8–9

thermionic emission 159–160

thin films 117–120, 124–125

total reflectance 186–188, 194

transmission electron microscopy (TEM)

  161, 166–172, 174–175

transmission mode, X-ray absorption

  spectroscopy 78–79, 84–85

triclinic crystal system 8

two-dimensional crystals 5

**U**

ultrahigh vacuum (UHV) environments 93–97, 105–106, 175

ultraviolet radiation 4

UV-Vis spectrometers 138–139, 183

**V**

vacuum capacitors 129–130, 136–137, 141–142

vacuum levels 93, 95–97

valence electrons 139, 159–161

vibrating sample magnetometers (VSM) 111, 113–116

vibrational transitions 43–48, 53–55, 59–60, 63–66

vibration-rotation bands 192

vibrations

  IR spectroscopy 191

  molecular 10

  normal modes 191

visible light 4, 138–139, 183

voltage integrator outputs 111  
 Von Laue treatment 15, 18–20, 27  
*VSM* see vibrating sample magnetometers

**W**  
 water-light interactions 44  
 wavelength selectors 51–52  
 Wyckoff position 34–35, 39–40

**X**  
*XANES* see X-ray near edge absorption spectroscopy  
*XPS* see X-ray photoelectron spectroscopy  
 X-ray absorption, electron microscopy 166  
 X-ray absorption spectroscopy (XAS) 77–92  
     analysis 86–92  
     Auger electrons 78–79, 84–86, 93–95  
     basic principles 77–83  
     electronic structures 86–92  
     electron yield mode 77–85  
     energy levels 78, 86, 89–90  
     examples 86–92  
     experimental aspects 83–86  
     fluorescence X-rays 78, 84–86, 100–101  
     fundamentals 77–83  
     instrumentation 83–86  
 $\text{La}_{x-1}\text{Ca}_x\text{MnO}_3$  86–88  
     photoelectrons 78, 80–86, 92–99  
 $\text{PrFe}_{1-x}\text{Mn}_x\text{O}_3$  88–92  
     spectral features 104–105  
     synchrotron radiation 83–84  
     theory 77  
     transmission mode 78–79, 84–85  
 X-ray Auger spectroscopy 78  
 X-ray diffraction (XRD) 15–42, 183  
     applications 27–40  
     Bragg's Law 17–18, 20–23, 27, 32  
     crystallography 183  
     crystal orientation 27–29  
     diffractometers 16, 21–24, 27–31  
     energy levels 15  
 $\text{EuFe}_{1-x}\text{Mn}_x\text{O}_3$  38–40  
     examples and illustrations 34–40  
     experimental techniques 20–21  
     forensic science 33–34  
     geological investigations 34  
     geometry 21–26  
     instrumentation 21–26  
     Laue treatment 15, 18–20, 27

$\text{La}_{x-1}\text{Ca}_x\text{MnO}_3$  37–38  
 orientation aspects 27–29  
 perovskites 34–40  
 pharmaceuticals 33–34  
 polycrystalline aggregates 29–33  
 powder method 21–23, 33–34  
 $\text{PrFe}_{1-x}\text{Mn}_x\text{O}_3$  34–36  
 quality 31–33  
 rotating crystal method 20–21  
 sample handling/holders 21–23, 27–28  
 single crystal orientation 27–29  
 source 22  
 standard pattern 26  
 X-ray emissions 100–101  
 X-ray microscopes 165–166  
 X-ray near edge absorption spectroscopy  
     (XANES) 80–82, 89–92  
 X-ray photoelectron spectroscopy (XPS) 78, 92–99  
     Auger electrons 93–95  
     basic principles 93–94  
     binding energy 93–99  
     energy referencing 94–95  
     Fermi levels 94–95  
     fundamentals 92–95  
     instrumentation 96–97  
     kinetic energy 92–97  
     spectra/features 97–99  
     spin-orbit interactions 98–99  
     ultrahigh vacuum environments 93, 95–97  
     vacuum levels 93, 95–97  
 X-rays  
     electromagnetic spectrum 4  
     electron interactions 160–167, 171, 179  
 X-ray spectroscopy 77–108  
     Auger electrons 78–79, 84–86, 93–95,  
         99–106  
     backscattering 80–81, 104–106  
     binding energy 77, 81, 93–99, 103  
     energy levels 77–83, 86–106  
     photon energy 78–82, 87–97  
 X-ray tubes 21–24  
 XRD see X-ray diffraction

**Z**  
 Zener double exchange 122  
 zero charge density, solids 11–12  
 zero-field-cooled (ZFC) magnetization 118–120, 125–126